

**Search Notes**

Application/Control No.

10/742,699

Examiner

Paul Contino

Applicant(s)/Patent under  
Reexamination

TANIGUCHI ET AL.

Art Unit

2114

**SEARCHED**

Class	Subclass	Date	Examiner
714	44	3/5/2007	PFC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
PGPub text search - see interference search printout		9/21/2006	PFC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search	9/18/2006	PFC
EAST (all databases searched)	9/19/2006	PFC
714/25,43,44 - text search [see included search report]	9/18/2006	PFC
358/1.14 - text search [see included search report]	3/5/2007	PFC
ACM/IEEE (+failure +predict +"second diagnosis"   +failure +predict second secondary testing diagnostic program)	3/5/2007	PFC
IEEE (+failure +predict +test/diagnostics/sis/second/ary)	3/5/2007	PFC